Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
09/581,583	MATSUYAMA ET AL.
Examiner	Art Unit

2134

Tongoc Tran

SEARCHED					
Class	Subclass	Date	Examiner		
380	281-286	8/9/2007	π		
380	44	8/9/2007	п		
713	169,170	8/13/2007	ΙT		
-					

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
380	281-286	8/9/2007	тт		
380	44	8/9/2007	π		
713	169,170	8/9/2007	П		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
East	8/9/2007	П	
Inventor name search	8/9/2007	π	
ACM, IEEE	8/13/2007	π	